

## 3.3V 4M × 64-Bit EDO-DRAM Module 3.3V 4M x 72-Bit EDO-DRAM Module

## 168pin unbuffered DIMM Module with serial presence detect

**HYM64V4005GU-50/-60**  
**HYM64V4045GU-50/-60**  
**HYM72V4005GU-50/-60**  
**HYM72V4045GU-50/-60**

- 168 Pin JEDEC Standard, Unbuffered 8 Byte Dual In-Line Memory Module for PC main memory applications
- 1 bank 4M x 64, 4M x 72 in 2k and 4k refresh organisations
- Optimized for byte-write non-parity or ECC applications
- Extended Data Out (EDO)
- Performance:

		-50	-60
tRAC	RAS Access Time	50 ns	60 ns
tCAC	CAS Access Time	13 ns	15 ns
tAA	Access Time from Address	25 ns	30 ns
tRC	Cycle Time	84 ns	104 ns
tHPC	EDO Mode Cycle Time	20 ns	25 ns

- Single +3.3 V ± 0.3 V Power Supply
- $\overline{\text{CAS}}$ -before- $\overline{\text{RAS}}$  refresh,  $\overline{\text{RAS}}$ -only-refresh
- Decoupling capacitors mounted on substrate
- All inputs, outputs and clocks are fully LV-TTL compatible
- Serial presence detects (optional)
- Utilizes 4M x 4 -DRAMs in TSOPII packages
- 2048 refresh cycles / 32 ms with 11 / 11 addressing ( Row / Column) for HYM64/72V4005GU
- 4096 refresh cycles / 64 ms with 12 / 10 addressing ( Row / Column) for HYM64/72V4045GU
- Gold contact pads
- Card Size: 133,35mm x 25,40 mm x 4,00 mm
- This DRAM product module family is intended to be fully pin and architecture compatible with the 168pin unbuffered SDRAM DIMM module family

The HYM64(72)V4005/45GU-50/-60 are industry standard 168-pin 8-byte Dual In-Line Memory Modules (DIMMs) which are organized as 4M x 64 and 4M x 72 high speed memory arrays designed with EDO DRAMs for non-parity and ECC applications. 2k refresh with 11 / 11 addressing and 4k refresh modules with 12 / 10 addressing are available. The DIMMs use sixteen 4M x 4 EDO DRAMs for the 4M x 64 organisation and eighteen 4M x 4 DRAMs for the 4M x 72 organisation, both in TSOPII packages. Decoupling capacitors are mounted on the PC board.

The DIMMs use optional serial presence detects implemented via a serial E<sup>2</sup>PROM using the two pin I<sup>2</sup>C protocol. The first 128 bytes are utilized by the DIMM manufacturer and the second 128 bytes of serial PD data are available to the customer.

All 168-pin DIMMs provide a high performance, flexible 8-byte interface in a 133,35 mm long space-saving footprint.

### Ordering Information

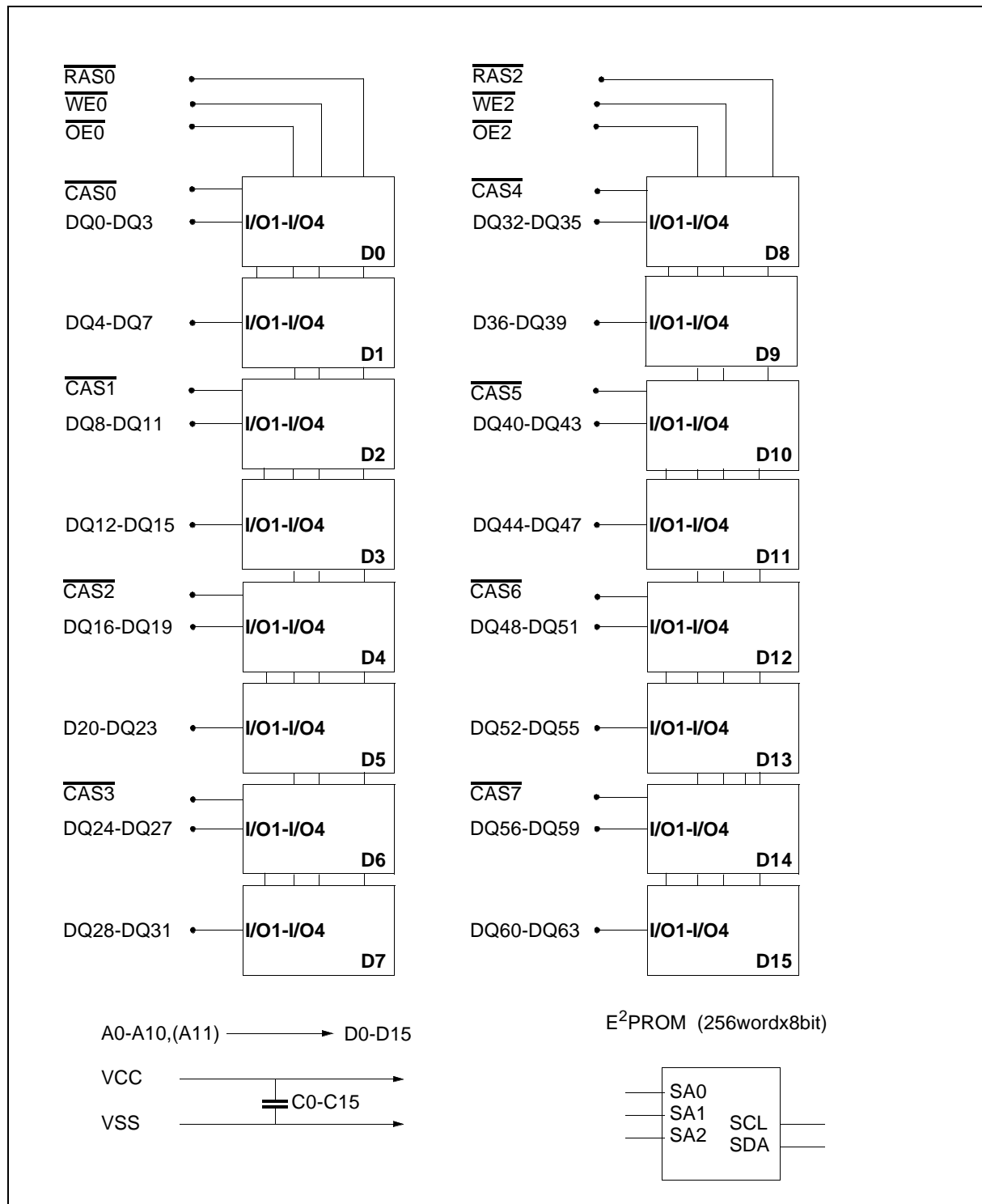
Type	Ordering Code	Package	Descriptions
<b>2k-Refresh:</b>			
HYM 64V4005GU-50	Q67100-Q2184	L-DIM-168-12	4M x 64 DRAM module (access time 50 ns)
HYM 64V4005GU-60	Q67100-Q2185	L-DIM-168-12	4M x 64 DRAM module (access time 60 ns)
HYM 72V4005GU-50	Q67100-Q2186	L-DIM-168-12	4M x 72 DRAM module (access time 50 ns)
HYM 72V4005GU-60	Q67100-Q2187	L-DIM-168-12	4M x 72 DRAM module (access time 60 ns)
<b>4k-Refresh:</b>			
HYM 64V4045GU-50		L-DIM-168-12	4M x 64 DRAM module (access time 50 ns)
HYM 64V4045GU-60		L-DIM-168-12	4M x 64 DRAM module (access time 60 ns)
HYM 72V4045GU-50		L-DIM-168-12	4M x 72 DRAM module (access time 50 ns)
HYM 72V4045GU-60		L-DIM-168-12	4M x 72 DRAM module (access time 60 ns)

### Pin Names

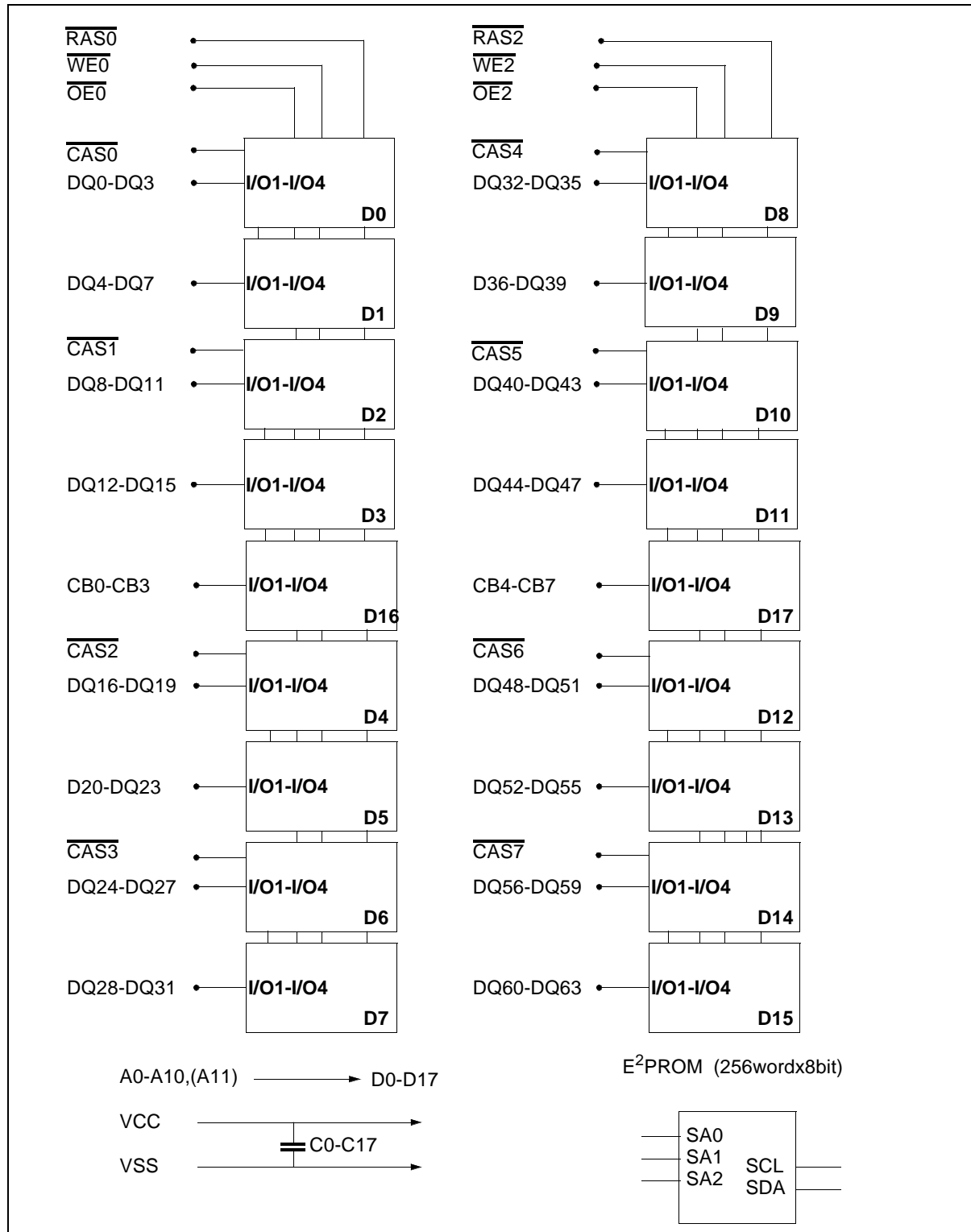
A0-A10	Row Address Input for HYB64/72V4005
A0-A10	Column Address Input for HYB64/72V4005
A0-A11	Row Address Input for HYB64/72V4045
A0-A9	Column Address Input for HYB64/72V4045
DQ0 - DQ63	Data Input/Output
CB0-CB7	Check Bit Data Input/Output ( x72 only)
RAS0, RAS2	Row Address Strobe
CAS0 - CAS7	Column Address Strobe
WE0, WE2	Read / Write Input
OE0, OE2	Output Enable
Vcc	Power (+3.3 Volt)
Vss	Ground
SCL	Clock for Presence Detect
SDA	Serial Data Out for Presence Detect
SA0-SA2	Serial Presence Detect Addresses
N.C.	No Connection
DU	Don't use

### Pin Configuration

PIN #	Symbol	PIN #	Symbol	PIN #	Symbol	PIN #	Symbol
1	VSS	43	VSS	85	VSS	127	VSS
2	DQ0	44	OE2	86	DQ32	128	DU
3	DQ1	45	RAS2	87	DQ33	129	NC
4	DQ2	46	CAS2	88	DQ34	130	CAS6
5	DQ3	47	CAS3	89	DQ35	131	CAS7
6	VCC	48	WE2	90	VCC	132	DU
7	DQ4	49	VCC	91	DQ36	133	VCC
8	DQ5	50	NC	92	DQ37	134	NC
9	DQ6	51	NC	93	DQ38	135	NC
10	DQ7	52	CB3	94	DQ39	136	CB6
11	DQ8	53	CB3	95	DQ40	137	CB7
12	VSS	54	VSS	96	VSS	138	VSS
13	DQ9	55	DQ16	97	DQ41	139	DQ48
14	DQ10	56	DQ17	98	DQ42	140	DQ49
15	DQ11	57	DQ18	99	DQ43	141	DQ50
16	DQ12	58	DQ19	100	DQ44	142	DQ51
17	DQ13	59	VCC	101	DQ45	143	VCC
18	VCC	60	DQ20	102	VCC	144	DQ52
19	DQ14	61	NC	103	DQ46	145	NC
20	DQ15	62	DU	104	DQ47	146	DU
21	CB0	63	NC	105	CB4	147	NC
22	CB1	64	VSS	106	CB5	148	VSS
23	VSS	65	DQ21	107	VSS	149	DQ53
24	NC	66	DQ22	108	NC	150	DQ54
25	NC	67	DQ23	109	NC	151	DQ55
26	VCC	68	VSS	110	VCC	152	VSS
27	WE0	69	DQ24	111	DU	153	DQ56
28	CAS0	70	DQ25	112	CAS4	154	DQ57
29	CAS1	71	DQ26	113	CAS5	155	DQ58
30	RAS0	72	DQ27	114	NC	156	DQ59
31	OE0	73	VCC	115	DU	157	VCC
32	VSS	74	DQ28	116	VSS	158	DQ60
33	A0	75	DQ29	117	A1	159	DQ61
34	A2	76	DQ30	118	A3	160	DQ62
35	A4	77	DQ31	119	A5	161	DQ63
36	A6	78	VSS	120	A7	162	VSS
37	A8	79	NC	121	A9	163	NC
38	A10	80	NC	122	A11	164	NC
39	NC	81	NC	123	NC	165	SA0
40	VCC	82	SDA	124	VCC	166	SA1
41	VCC	83	SCL	125	DU	167	SA2
42	DU	84	VCC	126	DU	168	VCC



**4M x 64 DIMM Module Block Diagram**



**4M x 72 DIMM Module Block Diagram**

### TRUTH TABLE

FUNCTION		$\overline{\text{RAS}}$	$\overline{\text{CAS}}$	$\overline{\text{WRITE}}$	$\overline{\text{OE}}$	ROW ADDR	COL ADDR	DQ0-DQ63
Standby		H	X	X	X	X	X	High Impedance
Read		L	L	H	L	ROW	COL	Data Out
Early-Write		L	L	L	X	ROW	COL	Data In
Late-Write		L	L	H - L	H	ROW	COL	Data In
Read-Modify-Write (RMW)		L	L	H - L	L - H	ROW	COL	Data Out, Data In
EDO Page Mode Read	1st Cycle	L	H - L	H	L	ROW	COL	Data Out
	2nd Cycle	L	H - L	H	L	n/a	COL	Data Out
EDO Page Mode Write	1st Cycle	L	H - L	L	X	ROW	COL	Data In
	2nd Cycle	L	H - L	L	X	n/a	COL	Data In
EDO Page Mode RMW	1st Cycle	L	H - L	H - L	L - H	ROW	COL	Data Out, Data In
	2st Cycle	L	H - L	H - L	L - H	n/a	COL	Data Out, Data In
$\overline{\text{RAS}}$ only refresh		L	H	X	X	ROW	n/a	High Impedance
$\overline{\text{CAS}}$ -before- $\overline{\text{RAS}}$ refresh		H - L	L	H	X	X	n/a	High Impedance
Hidden Refresh	READ	L-H-L	L	H	L	ROW	COL	Data Out
	WRITE	L-H-L	L	L	X	ROW	COL	Data In
Self Refresh		H - L	L	H	X	X	X	High Impedance

### Absolute Maximum Ratings

Operating temperature range .....	0 to + 70 °C
Storage temperature range.....	– 55 to + 125 °C
Input/output voltage .....	–0.5 to min (V <sub>CC</sub> +0.5, 4.6) V
Power supply voltage.....	–0.5 to 4.6 V
Power dissipation .....	9.94 W
Data out current (short circuit) .....	50 mA

**Note:** Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

### DC Characteristics

$T_A = 0$  to 70 °C;  $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$

Parameter	Symbol	x 64/ x72		Unit	Notes
		min.	max.		
Input high voltage	$V_{IH}$	2.0	$V_{CC} + 0.5$	V	1)
Input low voltage	$V_{IL}$	– 0.5	0.8	V	1)
Output high voltage (LVTTL) Output „H“level voltage ( $I_{OUT} = - 2\text{ mA}$ )	$V_{OH}$	2.4	–	V	1)
Output low voltage (LVTTL) Output „L“level voltage ( $I_{OUT} = + 2\text{ mA}$ )	$V_{OL}$	–	0.4	V	1)
Output high voltage (LVCMOS) Output „H“level voltage ( $I_{OUT} = - 100\mu\text{A}$ )	$V_{OH}$	$V_{CC}-0.2$	–	V	1)
Output low voltage (LVCMOS) Output „L“level voltage ( $I_{OUT} = +100\mu\text{A}$ )	$V_{OL}$	–	0.4	V	1)
Input leakage current ( $0\text{ V} < V_{IN} < V_{CC}$ , all other pins = 0 V)	$I_{I(L)}$	– 10	10	$\mu\text{A}$	1)
Output leakage current (DO is disabled, $0\text{ V} < V_{OUT} < V_{CC}$ )	$I_{O(L)}$	– 10	+10	$\mu\text{A}$	1)



### DC Characteristics for HYM64/72V4005

$T_A = 0 \text{ to } 70 \text{ }^\circ\text{C}$ ;  $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$

Parameter	Symbol	x 64		x 72		Unit	Notes
		min.	max.	min.	max.		
Average $V_{CC}$ supply current: -50 version -60 version  ( $\overline{\text{RAS}}$ , $\overline{\text{CAS}}$ , address cycling, $t_{RC}=t_{RC} \text{ min.}$ )	$I_{CC1}$	–	1920 1760	–	2160 1980	mA mA	2) 3) 4)
Standby $V_{CC}$ supply current ( $\overline{\text{RAS}} = \overline{\text{CAS}} = V_{IH}$ , one address change)	$I_{CC2}$	–	32	–	36	mA	–
Average $V_{CC}$ supply current during $\overline{\text{RAS}}$ only refresh cycles: -50 version -60 version  ( $\overline{\text{RAS}}$ cycling, $\overline{\text{CAS}} = V_{IH}$ , $t_{RC} = t_{RC} \text{ min.}$ )	$I_{CC3}$	–	1920 1760	–	2160 1980	mA mA	2) 4)
Average $V_{CC}$ supply current during hyper page mode (EDO): -50 version -60 version  ( $\overline{\text{RAS}} = V_{IL}$ , $\overline{\text{CAS}}$ , address cycling $t_{PC} = t_{PC} \text{ min.}$ )	$I_{CC4}$	–	1120 880	–	1260 990	mA mA	2) 3) 4)
Standby $V_{CC}$ supply current ( $\overline{\text{RAS}} = \overline{\text{CAS}} = V_{CC} - 0.2 \text{ V}$ , one address change)	$I_{CC5}$	–	16	–	18	mA	–
Average $V_{CC}$ supply current during $\overline{\text{CAS}}$ -before- $\overline{\text{RAS}}$ refresh mode: -50 version -60 version  ( $\overline{\text{RAS}}$ , $\overline{\text{CAS}}$ cycling, $t_{RC} = t_{RC} \text{ min.}$ )	$I_{CC6}$	–	1920 1760	–	2160 1980	mA mA	2) 4)

### DC Characteristics for HYM64/72V4045

$T_A = 0 \text{ to } 70 \text{ }^\circ\text{C}$ ;  $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$

Parameter	Symbol	x 64		x 72		Unit	Notes
		min.	max.	min.	max.		
Average $V_{CC}$ supply current: -50 version -60 version  ( $\overline{\text{RAS}}$ , $\overline{\text{CAS}}$ , address cycling, $t_{RC}=t_{RC} \text{ min.}$ )	$I_{CC1}$	– –	1600 1440	– –	1800 1620	mA mA	2) 3) 4)
Standby $V_{CC}$ supply current ( $\overline{\text{RAS}} = \overline{\text{CAS}} = V_{IH}$ , one address change)	$I_{CC2}$	–	32	–	36	mA	–
Average $V_{CC}$ supply current during $\overline{\text{RAS}}$ only refresh cycles: -50 version -60 version  ( $\overline{\text{RAS}}$ cycling, $\overline{\text{CAS}} = V_{IH}$ , $t_{RC} = t_{RC} \text{ min.}$ )	$I_{CC3}$	– –	1600 1440	– –	1800 1620	mA mA	2) 4)
Average $V_{CC}$ supply current during hyper page mode (EDO): -50 version -60 version  ( $\overline{\text{RAS}} = V_{IL}$ , $\overline{\text{CAS}}$ , address cycling $t_{PC} = t_{PC} \text{ min.}$ )	$I_{CC4}$	– –	1120 880	– –	1260 990	mA mA	2) 3) 4)
Standby $V_{CC}$ supply current ( $\overline{\text{RAS}} = \overline{\text{CAS}} = V_{CC} - 0.2 \text{ V}$ , one address change)	$I_{CC5}$	–	16	–	18	mA	–
Average $V_{CC}$ supply current during $\overline{\text{CAS}}$ -before- $\overline{\text{RAS}}$ refresh mode: -50 version -60 version  ( $\overline{\text{RAS}}$ , $\overline{\text{CAS}}$ cycling, $t_{RC} = t_{RC} \text{ min.}$ )	$I_{CC6}$	– –	1600 1440	– –	1800 1620	mA mA	2) 4)

### AC Characteristics <sup>5)6)</sup>

16E

 $T_A = 0 \text{ to } 70 \text{ }^\circ\text{C}, V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}, t_T = 2 \text{ ns}$ 

Parameter	Symbol	Limit Values				Unit	Note
		-50		-60			
		min.	max.	min.	max.		

#### common parameters

Random read or write cycle time	$t_{RC}$	84	—	104	—	ns	
$\overline{RAS}$ precharge time	$t_{RP}$	30	—	40	—	ns	
$\overline{RAS}$ pulse width	$t_{RAS}$	50	10k	60	10k	ns	
$\overline{CAS}$ pulse width	$t_{CAS}$	8	10k	10	10k	ns	
Row address setup time	$t_{ASR}$	0	—	0	—	ns	
Row address hold time	$t_{RAH}$	8	—	10	—	ns	
Column address setup time	$t_{ASC}$	0	—	0	—	ns	
Column address hold time	$t_{CAH}$	8	—	10	—	ns	
$\overline{RAS}$ to $\overline{CAS}$ delay time	$t_{RCD}$	12	37	14	45	ns	
$\overline{RAS}$ to column address delay	$t_{RAD}$	10	25	12	30	ns	
$\overline{RAS}$ hold time	$t_{RSH}$	13		15	—	ns	
$\overline{CAS}$ hold time	$t_{CSH}$	40		50	—	ns	
$\overline{CAS}$ to $\overline{RAS}$ precharge time	$t_{CRP}$	5	—	5	—	ns	
Transition time (rise and fall)	$t_T$	1	50	1	50	ns	7
Refresh period for 2k-refresh	$t_{REF}$	—	32	—	32	ms	
Refresh period for 4k-refresh	$t_{REF}$	—	64	—	64	ms	

#### Read Cycle

Access time from $\overline{RAS}$	$t_{RAC}$	—	50	—	60	ns	8, 9
Access time from $\overline{CAS}$	$t_{CAC}$	—	13	—	15	ns	8, 9
Access time from column address	$t_{AA}$	—	25	—	30	ns	8,10
$\overline{OE}$ access time	$t_{OEA}$	—	13	—	15	ns	
Column address to $\overline{RAS}$ lead time	$t_{RAL}$	25	—	30	—	ns	
Read command setup time	$t_{RCS}$	0	—	0	—	ns	
Read command hold time	$t_{RCH}$	0	—	0	—	ns	11
Read command hold time referenced to $\overline{RAS}$	$t_{RRH}$	0	—	0	—	ns	11
$\overline{CAS}$ to output in low-Z	$t_{CLZ}$	0	—	0	—	ns	8
Output buffer turn-off delay	$t_{OFF}$	0	13	0	15	ns	12

### AC Characteristics (cont'd) <sup>5)6)</sup>

16E

 $T_A = 0 \text{ to } 70^\circ\text{C}, V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}, t_T = 2 \text{ ns}$ 

Parameter	Symbol	Limit Values				Unit	Note
		-50		-60			
		min.	max.	min.	max.		
Output turn-off delay from $\overline{\text{OE}}$	$t_{\text{OEZ}}$	0	13	0	15	ns	12
Data to $\overline{\text{CAS}}$ low delay	$t_{\text{DZC}}$	0	—	0	—	ns	13
Data to $\overline{\text{OE}}$ low delay	$t_{\text{DZO}}$	0	—	0	—	ns	13
$\overline{\text{CAS}}$ high to data delay	$t_{\text{CDD}}$	10	—	13	—	ns	14
$\overline{\text{OE}}$ high to data delay	$t_{\text{ODD}}$	10	—	13	—	ns	14

### Write Cycle

Write command hold time	$t_{\text{WCH}}$	8	—	10	—	ns	
Write command pulse width	$t_{\text{Wp}}$	8	—	10	—	ns	
Write command setup time	$t_{\text{WCS}}$	0	—	0	—	ns	15
Write command to $\overline{\text{RAS}}$ lead time	$t_{\text{RWL}}$	13	—	15	—	ns	
Write command to $\overline{\text{CAS}}$ lead time	$t_{\text{CWL}}$	13	—	15	—	ns	
Data setup time	$t_{\text{DS}}$	0	—	0	—	ns	16
Data hold time	$t_{\text{DH}}$	8	—	10	—	ns	16

### Read-modify-Write Cycle

Read-write cycle time	$t_{\text{RWC}}$	113	—	138	—	ns	
$\overline{\text{RAS}}$ to $\overline{\text{WE}}$ delay time	$t_{\text{RWD}}$	64	—	77	—	ns	15
$\overline{\text{CAS}}$ to $\overline{\text{WE}}$ delay time	$t_{\text{CWD}}$	27	—	32	—	ns	15
Column address to $\overline{\text{WE}}$ delay time	$t_{\text{AWD}}$	39	—	47	—	ns	15
$\overline{\text{OE}}$ command hold time	$t_{\text{OEH}}$	10	—	13	—	ns	

### Hyper Page Mode (EDO) Cycle

EDO cycle time	$t_{\text{HPC}}$	20	—	25	—	ns	
$\overline{\text{CAS}}$ precharge time	$t_{\text{CP}}$	8	—	10	—	ns	
Access time from $\overline{\text{CAS}}$ precharge	$t_{\text{CPA}}$	—	27	—	32	ns	7
Output data hold time	$t_{\text{COH}}$	5	—	5	—	ns	
$\overline{\text{RAS}}$ pulse width in EDO mode	$t_{\text{RAS}}$	50	200k	60	200k	ns	
$\overline{\text{CAS}}$ precharge to $\overline{\text{RAS}}$ Delay	$t_{\text{RHPC}}$	27	—	32	—	ns	
$\overline{\text{OE}}$ setup time prior to $\overline{\text{CAS}}$	$t_{\text{OES}}$	5	—	5	—	ns	

### AC Characteristics (cont'd) <sup>5)6)</sup>

16E

 $T_A = 0 \text{ to } 70^\circ\text{C}, V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}, t_T = 2 \text{ ns}$ 

Parameter	Symbol	Limit Values				Unit	Note
		-50		-60			
		min.	max.	min.	max.		

#### Hyper Page Mode (EDO) Read-modify-Write Cycle

Hyper page mode (EDO) read-write cycle time	$t_{PRWC}$	58	—	68	—	ns	
$\overline{\text{CAS}}$ precharge to $\overline{\text{WE}}$	$t_{CPWD}$	41	—	49	—	ns	

#### $\overline{\text{CAS}}$ -before- $\overline{\text{RAS}}$ Refresh Cycle

$\overline{\text{CAS}}$ setup time	$t_{CSR}$	10	—	10	—	ns	
$\overline{\text{CAS}}$ hold time	$t_{CHR}$	10	—	10	—	ns	
$\overline{\text{RAS}}$ to $\overline{\text{CAS}}$ precharge time	$t_{RPC}$	5	—	5	—	ns	
Write to $\overline{\text{RAS}}$ precharge time	$t_{WRP}$	10	—	10	—	ns	
Write hold time referenced to $\overline{\text{RAS}}$	$t_{WRH}$	10	—	10	—	ns	

### Capacitance

 $T_A = 0 \text{ to } 70^\circ\text{C}; V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}; f = 1 \text{ MHz}$ 

Parameter	Symbol	Limit Values		Unit
		min.	max.	
Input Capacitance (A0 to A11)	$C_{I1}$	—	100	pF
Input Capacitance ( $\overline{\text{RAS0}}, \overline{\text{RAS2}}$ )	$C_{I2}$	—	75	pF
Input Capacitance ( $\overline{\text{CAS0}}, \overline{\text{CAS7}}$ )	$C_{I3}$	—	18	pF
Input Capacitance ( $\overline{\text{WE0}}, \overline{\text{WE2}}, \overline{\text{OE0}}, \overline{\text{OE2}}$ )	$C_{I4}$	—	75	pF
I/O Capacitance (DQ0-DQ63, CB0-CB8)	$C_{IO1}$	—	11	pF
Input Capacitance (SCL, SA0-2)	$C_S$	—	8	pF
Input/Output Capacitance (SDA)	$C_S$	—	10	pF

### Notes:

- 1) All voltages are referenced to  $V_{SS}$ .
- 2)  $I_{CC1}$ ,  $I_{CC3}$ ,  $I_{CC4}$  and  $I_{CC6}$  depend on cycle rate.
- 3)  $I_{CC1}$  and  $I_{CC4}$  depend on output loading. Specified values are obtained with the output open.
- 4) Address can be changed once or less while  $RAS = V_{IL}$ . In case of  $ICC4$  it can be changed once or less during a hyper page mode (EDO) cycle
- 5) An initial pause of 200  $\mu s$  is required after power-up followed by 8 RAS cycles of which at least one cycle has to be a refresh cycle, before proper device operation is achieved. In case of using the internal refresh counter, a minimum of 8 CAS-before-RAS initialization cycles instead of 8 RAS cycles are required.
- 6) AC measurements assume  $t_T = 2$  ns.
- 7)  $V_{IH (min.)}$  and  $V_{IL (max.)}$  are reference levels for measuring timing of input signals. Transition times are also measured between  $V_{IH}$  and  $V_{IL}$ .
- 8) Measured with the specified current load and 100 pF at  $V_{OL} = 0.8$  V and  $V_{OH} = 2.0$  V. Access time is determined by the latter of  $t_{RAC}$ ,  $t_{CAC}$ ,  $t_{AA}$ ,  $t_{CPA}$ ,  $t_{OEA}$ .  $t_{CAC}$  is measured from tristate.
- 9) Operation within the  $t_{RCD (max.)}$  limit ensures that  $t_{RAC (max.)}$  can be met.  $t_{RCD (max.)}$  is specified as a reference point only. If  $t_{RCD}$  is greater than the specified  $t_{RCD (max.)}$  limit, then access time is controlled by  $t_{CAC}$ .
- 10) Operation within the  $t_{RAD (max.)}$  limit ensures that  $t_{RAC (max.)}$  can be met.  $t_{RAD (max.)}$  is specified as a reference point only. If  $t_{RAD}$  is greater than the specified  $t_{RAD (max.)}$  limit, then access time is controlled by  $t_{AA}$ .
- 11) Either  $t_{RCH}$  or  $t_{RRH}$  must be satisfied for a read cycle.
- 12)  $t_{OFF (max.)}$ ,  $t_{OEZ (max.)}$  define the time at which the output achieves the open-circuit conditions and are not referenced to output voltage levels.  $t_{OFF}$  is referenced from the rising edge of  $\overline{RAS}$  or  $\overline{CAS}$ , whichever occurs last.
- 13) Either  $t_{DZC}$  or  $t_{DZO}$  must be satisfied.
- 14) Either  $t_{CDD}$  or  $t_{ODD}$  must be satisfied.
- 15)  $t_{WCS}$ ,  $t_{RWD}$ ,  $t_{CWD}$  and  $t_{AWD}$  are not restrictive operating parameters. They are included in the data sheet as electrical characteristics only. If  $t_{WCS} > t_{WCS (min.)}$ , the cycle is an early write cycle and data out pin will remain open-circuit (high impedance) through the entire cycle; if  $t_{RWD} > t_{RWD (min.)}$ ,  $t_{CWD} > t_{CWD (min.)}$  and  $t_{AWD} > t_{AWD (min.)}$ , the cycle is a read-write cycle and I/O will contain data read from the selected cells. If neither of the above sets of conditions is satisfied, the condition of I/O (at access time) is indeterminate.
- 16) These parameters are referenced to the  $\overline{CAS}$  leading edge in early write cycles and to the  $\overline{WE}$  leading edge in read-write cycles.

### Serial Presence Detects:

A serial presence detect storage device -- EEPROM 24C02 -- is assembled on to the module. Information about the modul confuguration, speed, etc. is written into the EEPROM device during module production using a serial presence detect protocol ( I<sup>2</sup>C synchronous 2-wire bus).

Byte# Description SPD Entry Value			Hex HYM			
			64 V4005 GU-50	64 V4005 GU-60	72 V4005 GU-50	72 V4005 GU-60
0	Number of SPD bytes	128	80	80	80	80
1	Total bytes in Serial PD	256	08	08	08	08
2	Memory Type	EDO	02	02	02	02
3	Number of Row Addresses	11	0B	0B	0B	0B
4	Number of Column Addresses	11	0B	0B	0B	0B
5	Number of DIMM Banks	1	01	01	01	01
6	Module Data Width	x64 / x72	40	40	48	48
7	Module Data Width (cont'd)	0	00	00	00	00
8	Module Interface Levels	LVTTTL	01	01	01	01
9	RAS access time	50 / 60 ns	32	3C	32	3C
10	CAS access time	13 / 15 ns	0D	0F	0D	0F
11	Dimm Config (Error Det/Corr.)	none / ECC	00	00	02	02
12	Refresh Rate/Type	normal 15.6µs	00	00	00	00
13	Primary DRAM data width	x4	04	04	04	04
14	Error checking DRAM data width	none / x4	00	00	04	04
15-31	reserved for future offerings		FF	FF	FF	FF
32	Superset Memory Type	NA	FF	FF	FF	FF
33-61	Superset information (may be used in future)	NA	FF	FF	FF	FF
62	SPD Revision Designator	Rev. 1.0	01	01	01	01
63	Checksum for bytes 0-62		XX	03	05	11
64-127	Manufacturer Information (optional)		FF	FF	FF	FF
128-255	Unused Storage Locations		FF	FF	FF	FF

### Serial Presence Detects (cont'd):

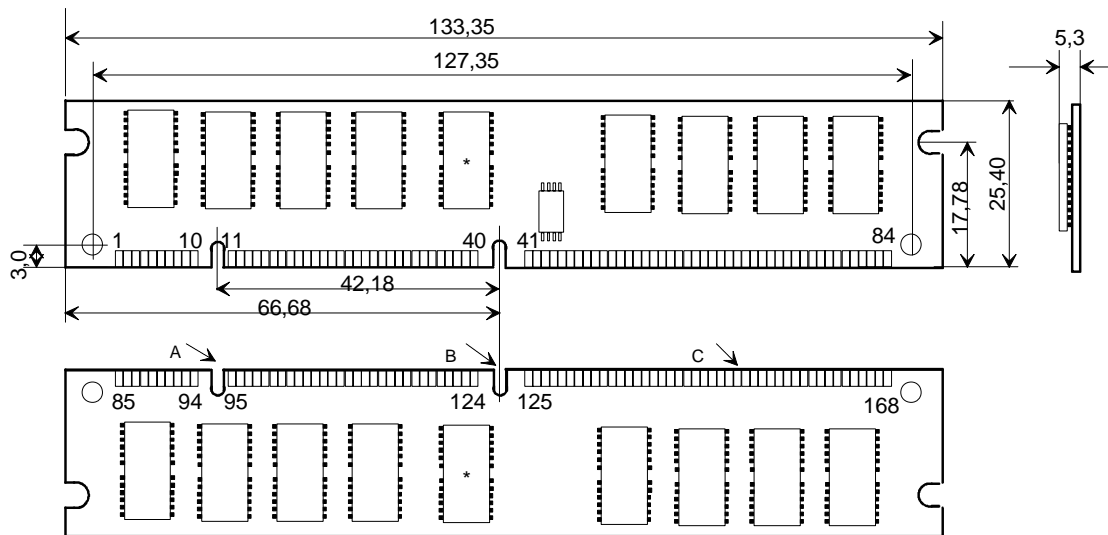
Byte# Description SPD Entry Value			Hex HYM			
			64 V4045 GU-50	64 V4045 GU-60	72 V4045 GU-50	72 V4045 GU-60
0	Number of SPD bytes	128	80	80	80	80
1	Total bytes in Serial PD	256	08	08	08	08
2	Memory Type	EDO	02	02	02	02
3	Number of Row Addresses	12	0C	0C	0C	0C
4	Number of Column Addresses	10	0A	0A	0A	0A
5	Number of DIMM Banks	1	01	01	01	01
6	Module Data Width	x64 / x72	40	40	48	48
7	Module Data Width (cont'd)	0	00	00	00	00
8	Module Interface Levels	LVTTL	01	01	01	01
9	RAS access time	50 / 60 0 ns	32	3C	32	3C
10	CAS access time	13 / 150 ns	0D	0F	0D	0F
11	Dimm Config (Error Det/Corr.)	none / ECC	00	00	02	02
12	Refresh Rate/Type	normal 15.6µs	00	00	00	00
13	Primary DRAM Organisation	x4	04	04	04	04
14	Secondary DRAM Organisation	undefined	00	00	00	00
15-31	reserved for future offerings		FF	FF	FF	FF
32	Superset Memory Type	NA	FF	FF	FF	FF
33-61	Superset information (may be used in future)	NA	FF	FF	FF	FF
62	SPD Revision Designator	Rev. 1.0	01	01	01	01
63	Checksum for bytes 0-62		XX	03	XX	0D
64-127	Manufacturer Information (optional)		FF	FF	FF	FF
128-255	Unused Storage Locations		FF	FF	FF	FF



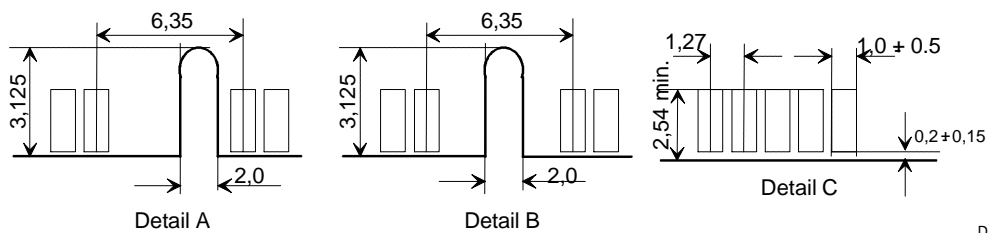
**L-DIM-168-12**

## Module package

**(168 pin, dual read-out, single in-line memory module)**



\* On x72 only (CB0-CB7)



DM168-12.WMF

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preliminary drawing
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